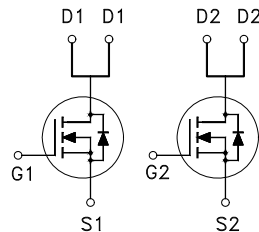


Dual N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

BV_{DSS}	60V
$R_{DS(on)} (MAX.)$	60m Ω
I_D	6A



UIS, Rg 100% Tested

Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_A = 25^\circ\text{C}$	I_D	6	A
	$T_A = 100^\circ\text{C}$		4.3	
Pulsed Drain Current ¹		I_{DM}	24	
Avalanche Current		I_{AS}	12	mJ
Avalanche Energy	$L = 0.1\text{mH}, I_D = 10\text{A}, R_G = 25\Omega$	E_{AS}	5	
Repetitive Avalanche Energy ²	$L = 0.05\text{mH}$	E_{AR}	2.5	
Power Dissipation	$T_A = 25^\circ\text{C}$	P_D	2.27	W
	$T_A = 100^\circ\text{C}$		0.9	
Operating Junction & Storage Temperature Range		T_{j}, T_{stg}	-55 to 150	$^\circ\text{C}$

100% UIS testing in condition of $V_D = 15\text{V}$, $L = 0.1\text{mH}$, $V_G = 10\text{V}$, $I_L = 7.5\text{A}$, Rated $V_{DS} = 30\text{V}$ N-CH

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	$R_{\theta JC}$		7.5	$^\circ\text{C} / \text{W}$
Junction-to-Ambient ³	$R_{\theta JA}$		55	

¹Pulse width limited by maximum junction temperature.

²Duty cycle $\leq 1\%$

³55 $^\circ\text{C} / \text{W}$ when mounted on a 1 in² pad of 2 oz copper.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT	
			MIN	TYP	MAX		
STATIC							
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60			V	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.0	2.0	3.2		
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$			± 100	nA	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 48V, V_{GS} = 0V$			1	μA	
		$V_{DS} = 40V, V_{GS} = 0V, T_J = 125\text{ }^{\circ}C$			25		
On-State Drain Current ¹	$I_{D(ON)}$	$V_{DS} = 10V, V_{GS} = 10V$	6			A	
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 6A$		50	60	m Ω	
		$V_{GS} = 4.5V, I_D = 4A$		70	85		
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 6A$		13		S	
DYNAMIC							
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 15V, f = 1MHz$		633		pF	
Output Capacitance	C_{oss}			67			
Reverse Transfer Capacitance	C_{rss}			44			
Gate Resistance	R_g	$V_{GS} = 15mV, V_{DS} = 0V, f = 1MHz$		2.5		Ω	
Total Gate Charge ^{1,2}	$Q_g(V_{GS}=10V)$	$V_{DS} = 15V, V_{GS} = 10V,$ $I_D = 6A$		13.8		nC	
	$Q_g(V_{GS}=4.5V)$			7.2			
Gate-Source Charge ^{1,2}	Q_{gs}			2.8			
Gate-Drain Charge ^{1,2}	Q_{gd}			4.0			
Turn-On Delay Time ^{1,2}	$t_{d(on)}$	$V_{DS} = 15V,$ $I_D = 1A, V_{GS} = 10V, R_{GS} = 6\Omega$		10		nS	
Rise Time ^{1,2}	t_r			7.5			
Turn-Off Delay Time ^{1,2}	$t_{d(off)}$			15			
Fall Time ^{1,2}	t_f			10			
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _A = 25 °C)							
Continuous Current	I_S				2.3	A	
Pulsed Current ³	I_{SM}				9.2		
Forward Voltage ¹	V_{SD}	$I_F = I_S, V_{GS} = 0V$			1.2	V	
Reverse Recovery Time	t_{rr}	$I_F = I_S, di_F/dt = 100A / \mu S$		15		nS	
Reverse Recovery Charge	Q_{rr}			8		nC	

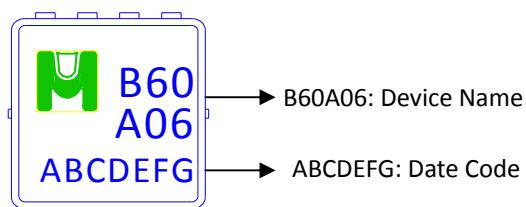
¹Pulse test : Pulse Width $\leq 300 \mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

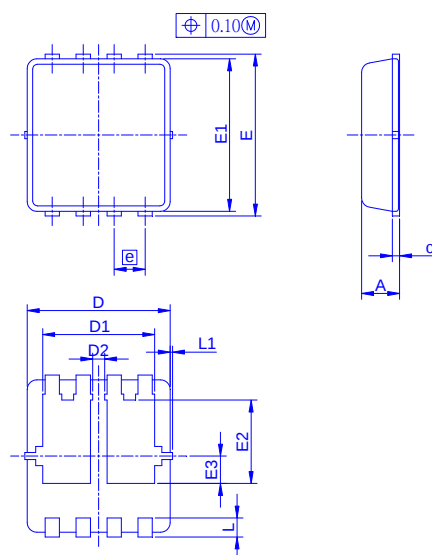
³Pulse width limited by maximum junction temperature.

Ordering & Marking Information:

Device Name: EMB60A06V for EDFN 3 x 3



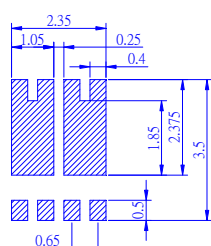
Outline Drawing



Dimension in mm

Dimension	A	A1	b	c	D	D1	D2	E	E1	E2	E3	e	L	L1	Θ1
Min.	0.70	0	0.24	0.10	2.95	2.25		3.15	2.95	1.65			0.30	0	0°
Typ.	0.80		0.30	0.152	3.00	2.35	0.225	3.20	3.00	1.75	0.575	0.65	0.40		10°
Max.	0.90	0.05	0.35	0.25	3.05	2.45		3.25	3.05	1.85			0.50	0.10	12°

Recommended minimum pads





TYPICAL CHARACTERISTICS

